



ESD



TVS



MOS



LDO



Diode



Sensor



DC-DC

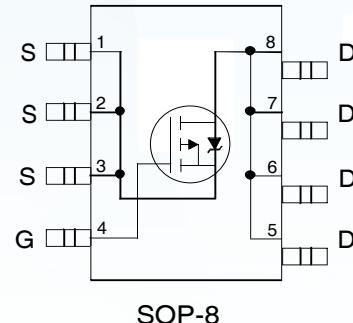
## Product Specification

▶ Domestic Part Number	IRF7404
▶ Overseas Part Number	IRF7404
▶ Equivalent Part Number	IRF7404



**P-Channel MOSFET**
**Features**

- $V_{DS} (v) = -55V$
- $R_{DS(ON)} < 20 \text{ m}\Omega$  ( $V_{GS} = -4.5V$ )
- $R_{DS(ON)} < 60 \text{ m}\Omega$  ( $V_{GS} = -2.7V$ )
- Generation V Technology
- Ultra Low On-Resistance
- Surface Mount
- Dynamic dv/dt Rating
- Fast Switching
- Lead-Free


**Description**

The SOP-8 has been modified through a customized leadframe for enhanced thermal characteristics and multiple-die capability making it ideal in a variety of power applications. With these improvements, multiple devices can be used in an application with dramatically reduced board space. The package is designed for vapor phase, infrared, or wave soldering techniques. Power dissipation of greater than 0.8W is possible in a typical PCB mount application.

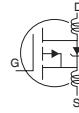
**Absolute Maximum Ratings**

	Parameter	Max.	Units
$I_D @ T_A = 25^\circ\text{C}$	10 Sec. Pulsed Drain Current, $V_{GS} @ -4.5V$	-7.7	A
$I_D @ T_A = 25^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ -4.5V$	-6.7	
$I_D @ T_A = 70^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ -4.5V$	-5.4	
$I_{DM}$	Pulsed Drain Current ①	-27	
$P_D @ T_A = 25^\circ\text{C}$	Power Dissipation	2.5	W
	Linear Derating Factor	0.02	W/ $^\circ\text{C}$
$V_{GS}$	Gate-to-Source Voltage	$\pm 12$	V
$dv/dt$	Peak Diode Recovery $dv/dt$ ②	-5.0	V/ns
$T_J, T_{STG}$	Junction and Storage Temperature Range	-55 to +150	$^\circ\text{C}$

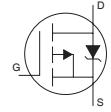
**Thermal Resistance Ratings**

	Parameter	Typ.	Max.	Units
$R_{\theta JA}$	Maximum Junction-to-Ambient ④		50	$^\circ\text{C/W}$

**P-Channel MOSFET****Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

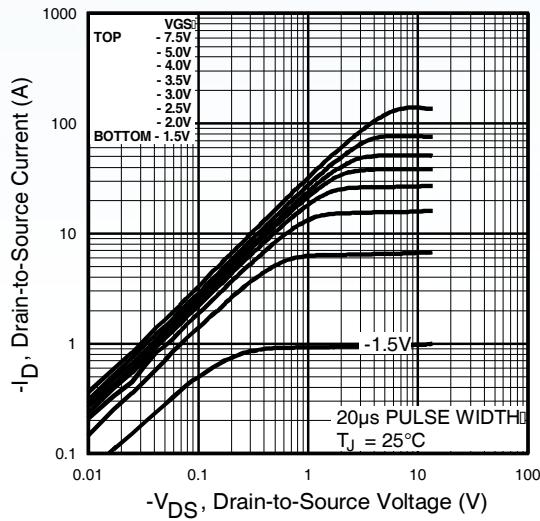
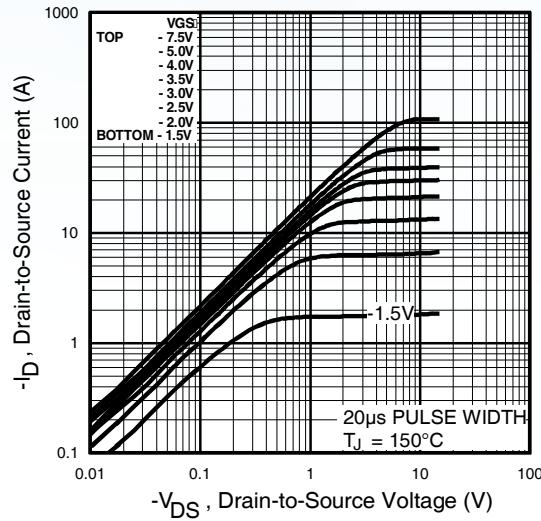
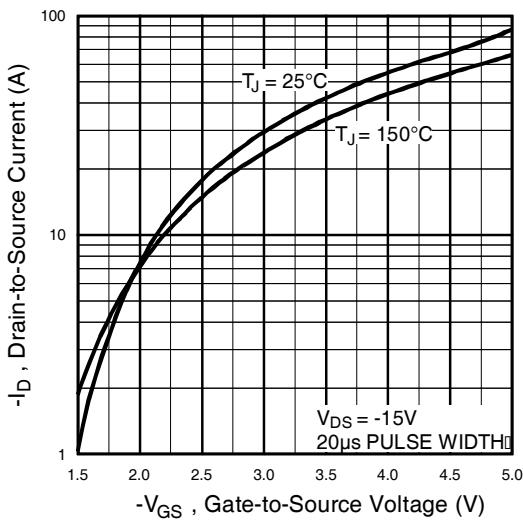
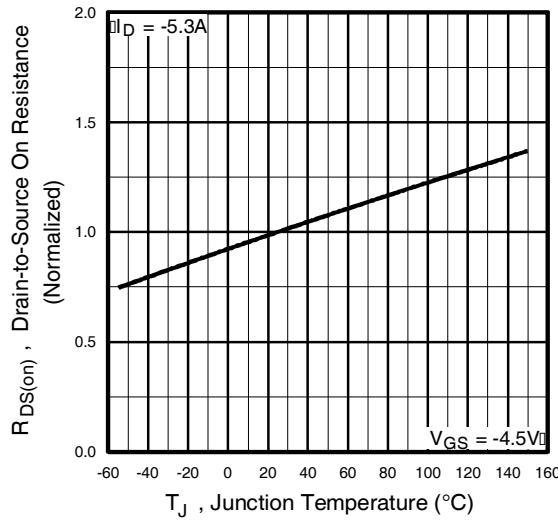
	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	-20			V	$V_{GS} = 0V, I_D = -250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient		-0.012		V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}, I_D = -1\text{mA}$
$R_{DS(\text{ON})}$	Static Drain-to-Source On-Resistance		40	$\text{m}\Omega$	$V_{GS} = -4.5V, I_D = -3.2\text{A}$ ③	
			60		$V_{GS} = -2.7V, I_D = -2.7\text{A}$ ③	
$V_{GS(\text{th})}$	Gate Threshold Voltage	-0.70			V	$V_{DS} = V_{GS}, I_D = -250\mu\text{A}$
$g_f$	Forward Transconductance	6.8			S	$V_{DS} = -15V, I_D = -3.2\text{A}$
$I_{\text{DSS}}$	Drain-to-Source Leakage Current		-1.0	$\mu\text{A}$	$V_{DS} = -16V, V_{GS} = 0V$	
			-25		$V_{DS} = -16V, V_{GS} = 0V, T_J = 125^\circ\text{C}$	
$I_{GSS}$	Gate-to-Source Forward Leakage		-100	$\text{nA}$	$V_{GS} = -12V$	
	Gate-to-Source Reverse Leakage		100		$V_{GS} = 12V$	
$Q_g$	Total Gate Charge		50	$\text{nC}$	$I_D = -3.2\text{A}$	
$Q_{gs}$	Gate-to-Source Charge		5.5		$V_{DS} = -16V$	
$Q_{qd}$	Gate-to-Drain ("Miller") Charge		21		$V_{GS} = -4.5V, \text{See Fig. 6 and 12}$ ③	
$t_{d(on)}$	Turn-On Delay Time		14	$\text{ns}$	$V_{DD} = -10V$	
$t_r$	Rise Time		32		$I_D = -3.2\text{A}$	
$t_{d(off)}$	Turn-Off Delay Time		100		$R_G = 6.0\Omega$	
$t$	Fall Time		65		$R_D = 3.1\Omega, \text{See Fig. 10}$ ③	
$L_D$	Internal Drain Inductance		2.5	$\text{nH}$	Between lead tip and center of die contact	
$L_S$	Internal Source Inductance		4.0			
$C_{iss}$	Input Capacitance	1500			$V_{GS} = 0V$	
$C_{oss}$	Output Capacitance	730		$\text{pF}$	$V_{DS} = -15V$	
$C_{rss}$	Reverse Transfer Capacitance	340			$f = 1.0\text{MHz}, \text{See Fig. 5}$	

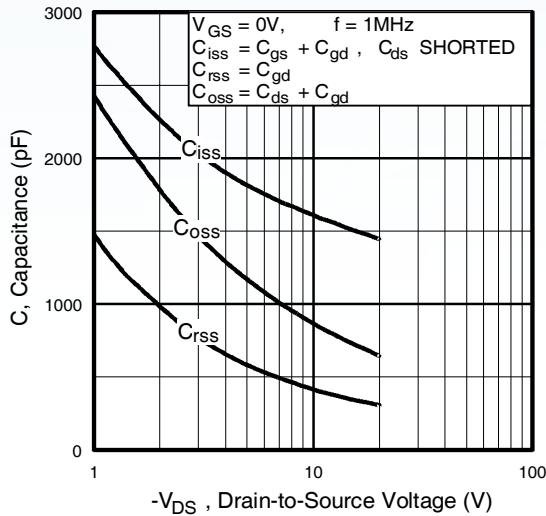
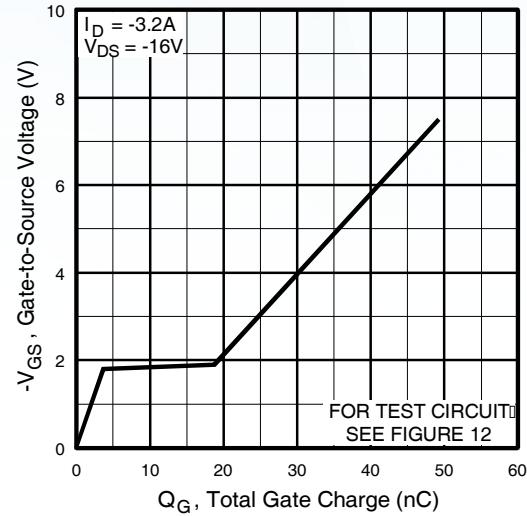
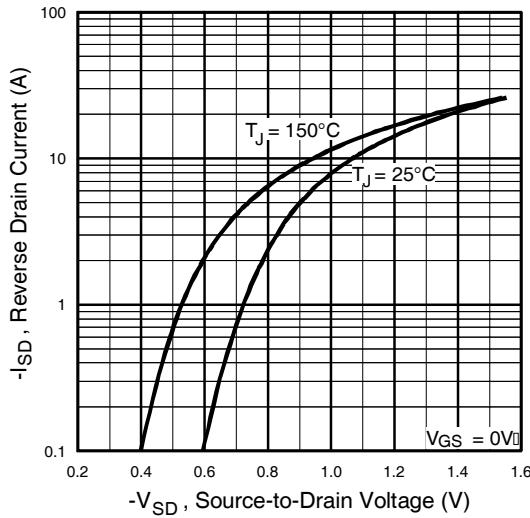
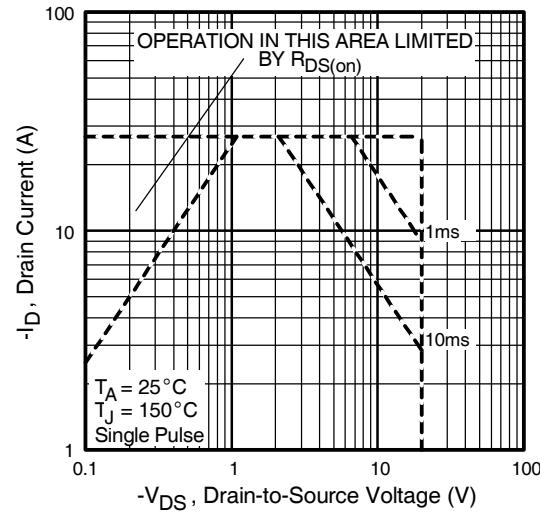
**Source-Drain Ratings and Characteristics**

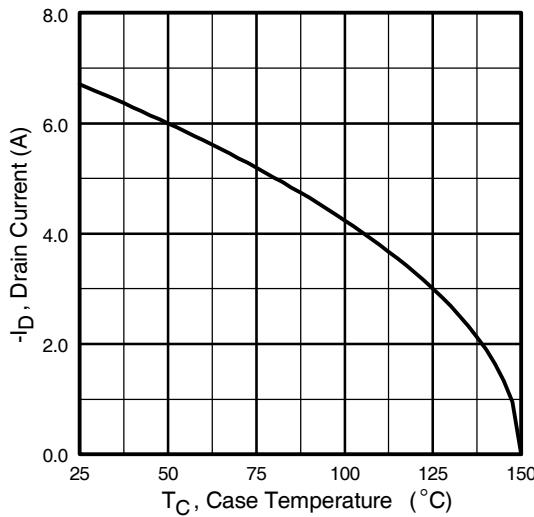
	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)			-3.1	$\text{A}$	MOSFET symbol showing the integral reverse p-n junction diode.
$I_{SM}$	Pulsed Source Current (Body Diode) ①			-27		
$V_{SD}$	Diode Forward Voltage			-1.0	V	$T_J = 25^\circ\text{C}, I_S = -2.0\text{A}, V_{GS} = 0V$ ③
$t_{rr}$	Reverse Recovery Time		69	100	ns	$T_J = 25^\circ\text{C}, I_F = -3.2\text{A}$ $di/dt = 100\text{A}/\mu\text{s}$ ③
$Q_{rr}$	Reverse Recovery Charge		71	110	$\mu\text{C}$	
$t_{on}$	Forward Turn-On Time					Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$ )

**Notes:**

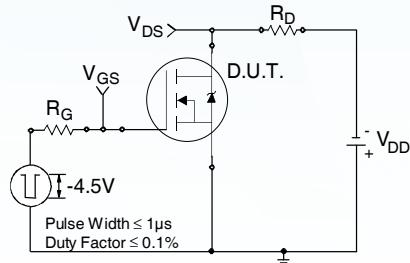
- ① Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 11 )
- ②  $I_{SD} \leq -3.2\text{A}$ ,  $di/dt \leq -65\text{A}/\mu\text{s}$ ,  $V_{DD} \leq V_{(\text{BR})\text{DSS}}$ ,  $T_J \leq 150^\circ\text{C}$
- ③ Pulse width  $\leq 300\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ④ Surface mounted on FR-4 board,  $t \leq 10\text{sec}$ .

**P-Channel MOSFET****Fig 1.** Typical Output Characteristics**Fig 2.** Typical Output Characteristics**Fig 3.** Typical Transfer Characteristics**Fig 4.** Normalized On-Resistance Vs. Temperature

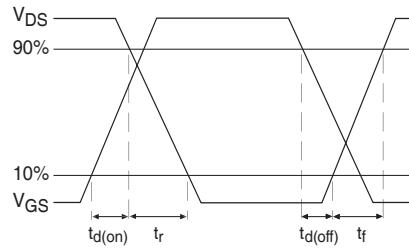
**P-Channel MOSFET**

**Fig 5.** Typical Capacitance Vs.  
Drain-to-Source Voltage

**Fig 6.** Typical Gate Charge Vs.  
Gate-to-Source Voltage

**Fig 7.** Typical Source-Drain Diode  
Forward Voltage

**Fig 8.** Maximum Safe Operating Area

**P-Channel MOSFET**

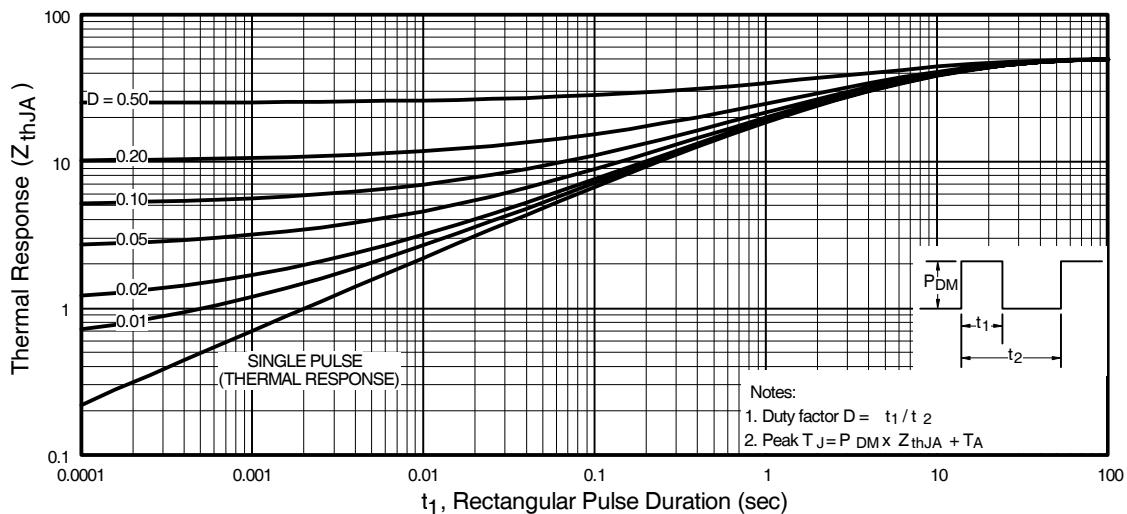
**Fig 9.** Maximum Drain Current Vs.  
Ambient Temperature



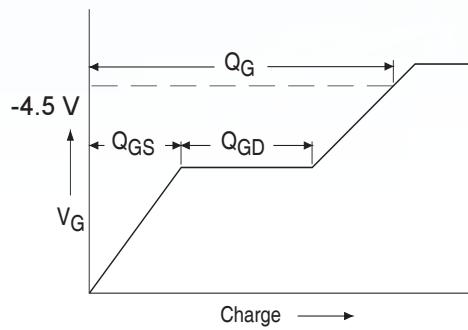
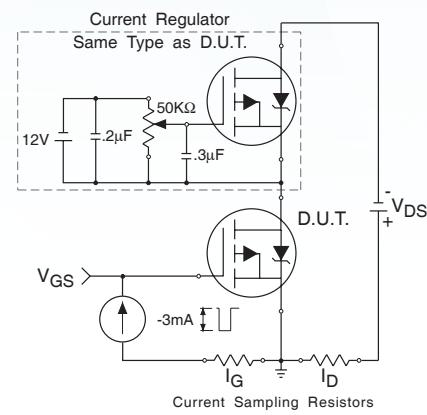
**Fig 10a.** Switching Time Test Circuit



**Fig 10b.** Switching Time Waveforms

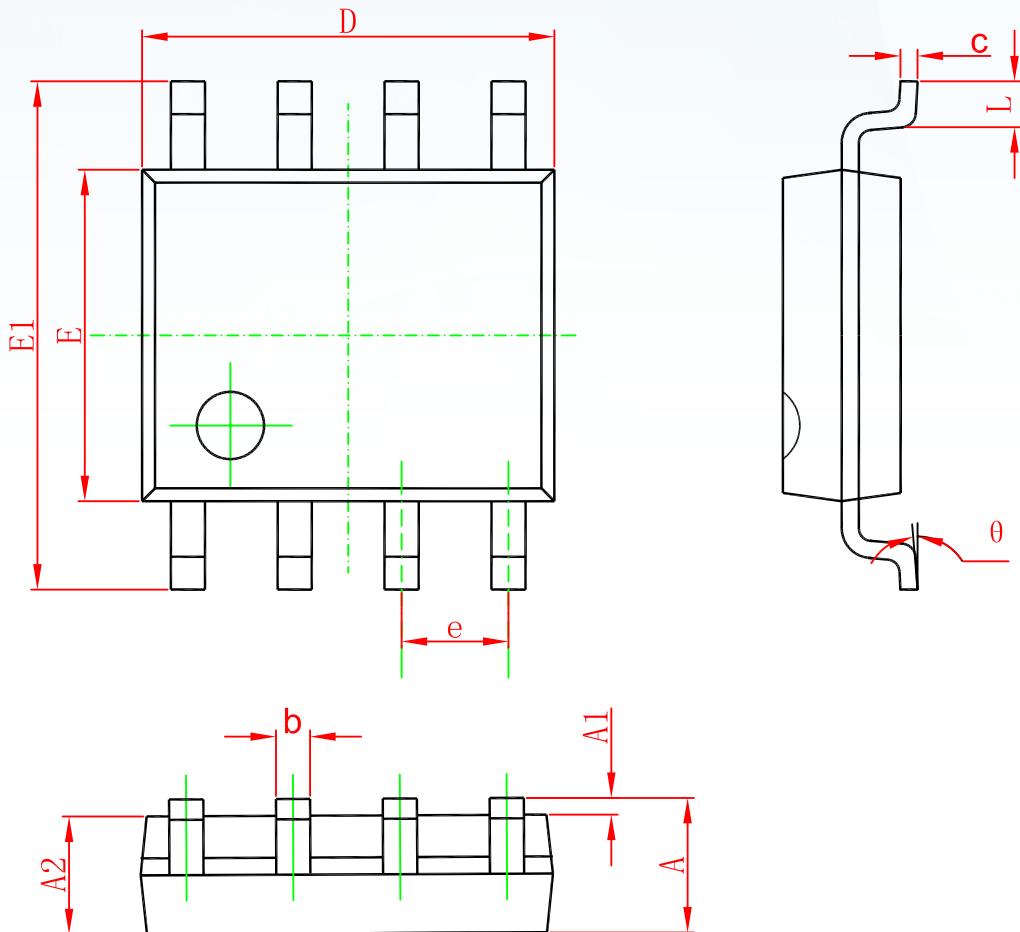


**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

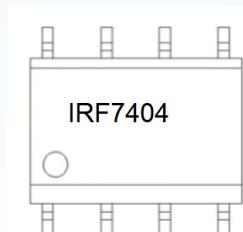
**P-Channel MOSFET****Fig 12a.** Basic Gate Charge Waveform**Fig 12b.** Gate Charge Test Circuit

## P-Channel MOSFET

SOP-8



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.350	1.750	0.053	0.069
A1	0.100	0.250	0.004	0.010
A2	1.350	1.550	0.053	0.061
b	0.330	0.510	0.013	0.020
c	0.170	0.250	0.006	0.010
D	4.700	5.100	0.185	0.200
E	3.800	4.000	0.150	0.157
E1	5.800	6.200	0.228	0.244
e	1.270(BSC)		0.050(BSC)	
L	0.400	1.270	0.016	0.050
$\theta$	0°	8°	0°	8°

**P-Channel MOSFET****Marking****Ordering information**

Order code	Package	Baseqty	Deliverymode
IRF7404	SOP-8	3000	Tape and reel

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